

Notice of References Cited	Application/Control No. 10/563,124		Applicant(s)/Patent Under Reexamination ABE ET AL.	
	Examiner Kwang Han		Art Unit 1795	Page 1 of 1

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*	B	US-2003/0087155	05-2003	Cho et al.	429/231.95
*	C	US-5,153,082	10-1992	Ogino et al.	429/231.4
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	M	US-			

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NON-PATENT DOCUMENTS

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	U	AIPN online translation of JP 2002-158035, Hibara et al., May 31, 2002
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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